## COE 464, Term 042

## Testing of Digital Circuits

## Quiz\# 1

Date: Sunday, Feb. 27, 2005

Q1. Consider the circuit given below:

i. Find a Boolean expression for the set of all tests that detect the fault $\mathrm{x}_{3} \mathrm{~s}-\mathrm{a}-0$.
ii. Mark on the circuit all the possible single stuck-at faults using the symbol s0 for stuck-at-0 faults and the symbol s1 for stuck-at-1 faults.
iii. Mark on the circuit all the single stuck-at faults that can be eliminated due to Fault Equivalence relation by drawing a circuit around them.
iv. Mark on the circuit all the single stuck-at faults that can be eliminated due to Fault Dominance relation by drawing a square around them.

